Complex pulsed field magnetization behavior and Walker breakdown in a NiFe thin-film

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(Received 8 February 2010; accepted 19 August 2010; published online 13 October 2010)

The magnetization behavior of a Permalloy thin-film (nominally Ni$_{80}$Fe$_{20}$) was investigated as a function of combined quasistatic and pulsed magnetic fields measured using magneto-optic Kerr effect magnetometry. We observed complex field dependent switching behavior that depends on the relative contributions to the total field of the quasistatic and pulsed fields. As the pulsed field amplitude was increased, complex switching behavior occurs for total fields in excess of the coercive field. A simple phenomenological domain wall propagation model suggests a qualitative understanding of this complex behavior based on Walker breakdown of the domain wall motion occurring in the Permalloy thin-film. © 2010 American Institute of Physics.

[doi:10.1063/1.3490233]

I. INTRODUCTION

The magnetization behavior of magnetic thin-films is of basic interest and also relevant to technological applications such as sensors, electronic components, and recording media. Magnetization reversal can take place through various processes from domain wall propagation to quasicoherent rotation. The dominant processes are determined by the energetics of the system that includes a number of contributions such as anisotropy and exchange, they are also dependent upon the timescale and amplitude of the applied magnetic field and can be thermally assisted.

For Permalloy thin-films (compositions around Ni$_{81}$Fe$_{19}$) the magnetization process typically involves nucleation and propagation of domain walls throughout the film. The domain wall propagation velocity in Permalloy thin-films has been determined experimentally by several groups and it was shown that the velocity increases monotonically with field and the field dependence of the wall velocity may be divided into two regimes: a high-field regime controlled by gyromagnetic damping; and a low-field regime where the velocity indicative of Walker breakdown; similar behavior has subsequently been observed by others in Permalloy nanowires. Therefore, in principle the magnetization behavior of thin-films, such as NiFe, in pulsed magnetic fields may result in complex field dependence of the magnetization arising from the complexity of the domain wall dynamics.

Here the magnetization switching behavior in an unstructured Permalloy thin-film was studied with a combination of pulsed and quasistatic magnetic fields applied along the same axis. The results are interpreted using a phenomenological model based upon the depinning and propagation of a single domain wall, where the field dependence of the domain wall propagation includes Walker breakdown.

II. EXPERIMENTAL DETAILS

The sample investigated was fabricated by thermal evaporation through a shadow mask onto a on a 5 × 5 mm silicon substrate with a 500 nm thick hydrothermally oxidized SiO$_2$ surface layer. The evaporation base pressure was approximately 10$^{-7}$ Torr and the deposition rate of the order of 1 Å s$^{-1}$. The sample consisted of a 400 µm wide microstrip line made of a 30 nm thick aluminum layer with a 15 nm thick Ni$_{81}$Fe$_{19}$ layer deposited directly on top through the same shadow mask without breaking the vacuum and in the absence of a magnetic field. The layer thicknesses were determined during deposition using an in situ quartz crystal oscillator that was externally calibrated to thicknesses determined from x-ray reflectivity measurements.

The silicon substrate base was fixed to an earthed sample holder and the microstrip on top of the substrate was connected at each end to the center pins of 50 Ω coaxial connectors using conductive silver paint. The sample holder was positioned within the poles of an electromagnet supplying a quasistatic field. The microstrip was connected via the coaxial connectors to an impedance matched pulsed current generator circuit. Flat-topped current pulses were used to produce pulsed magnetic fields of widths from 10 ns up to 1 µs across the microstrip line. Figure 1 shows a schematic
of the sample showing the microstrip structure and the orientation of the applied magnetic fields. In this study the effect on magnetization reversal of combining both pulsed and quasistatic magnetic fields was investigated.

A focused longitudinal magneto-optical Kerr effect (MOKE) optical system was used to determine the magnetization state resulting after the application of the total field along the axis of the applied fields. The laser spot focused onto the sample was elliptical and around 10 μm in size.

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The field-current relationship for the microstrip was calibrated by passing a small dc current through the microstrip. This introduced a small static field shift to the electromagnet, which is measured with a magnetic field at 27 Hz. The magnetization behavior for the thin-film was obtained by recording the hysteresis loops for a range of pulsed field magnitudes at fixed bias fields. The change in magnetization is small if switching was mostly unsuccessful and large if the sample was switched during every field cycle. The relative contributions to the total field of the pulsed and bias components were varied and the experiment was repeated. Both positive and negative bias fields were investigated and were repeated for a range of different pulse widths.

To aid interpretation of the results obtained, a simple model was developed where magnetization switching takes place by field driven domain wall propagation. The model takes into account the domain wall propagation characteristics resulting from both the short duration pulsed fields and the bias fields used in the experiment.

### III. RESULTS AND DISCUSSION

Figure 2 shows the quasistatic (27 Hz) magnetization behavior of the Permalloy thin-film sample measured using the MOKE system. The sample shows ferromagnetic behavior with a quasistatic coercivity of 3 Oe, which is typical for films of this material and thickness, and the material reaches saturation around 10 Oe. The film has a high remanence ratio of over 0.8 indicating a large magnetization component along the applied field axis and MOKE measurement axis. Note that the sample fabrication with microstrip line geometry in this investigation restricts pulsed fields to be applied only along one axis.

Before application of the pulsed field, the quasistatic 27 Hz ac signal and dc offset from the electromagnet were used to initialize the magnetization state before the pulsed magnetic field was triggered. As described earlier, the bias field was adjusted until rapid switching of the film through the coercive point was no longer achieved, as shown in Fig. 3(a).

By applying a 1 μs pulsed magnetic field coinciding with the maximum positive quasistatic field, partial or complete magnetization switching was restored, depending upon the amplitude of the pulsed field, as shown in Figs. 3(b)–3(d).
The normalized change in magnetization from negative saturation to the maximum magnetization in Fig. 3 is shown as a function of pulsed field amplitude in Fig. 4. The effect of different bias fields on the switching behavior is also shown in this figure. The same data is replotted in Fig. 4 as a function of the total field, the sum of both the pulsed and bias fields. The data sets all initially rise at the same total field within a spread of <0.5 Oe, which is within the resolution of the calibration for the electromagnet, showing that for a fixed pulse width the switching field for the thin-film is dependent on the total field combining the relative contributions from the pulsed and bias fields.

The changes in pulsed field magnetization switching as a function of the bias field are complex. At the largest positive bias field simple steplike field dependent switching behavior occurs. However, with a decreased bias, the rapid rise in magnetization with field is followed by a fall in magnetization level at higher fields. When the bias is negative the switching becomes more complex as the magnetization rises to a peak then falls significantly and rises again as the pulsed field level increases further. For the small positive bias and the negative bias fields the final magnetization state is one of incomplete switching even though the maximum in the total field during the pulse is in excess of the switching field.

Figure 5 shows the change in magnetization for the sample as a function of total applied field for pulse widths of about 1 μs, 500 ns, and 10 ns and for both positive and negative bias fields.
negative bias fields. For positive bias fields, as shown in Fig. 5(a), the pulse width has little effect on the switching behavior taking place, with perhaps a small increase in the switching field at the shortest pulse timescale. In contrast, with negative bias fields, Fig. 5(b), there is a significant pulse width dependence of the magnetization switching behavior and it can be seen that the field at which the initial magnetization switching occurs decreases with increasing pulse width, which is consistent with thermally activated pulsed field switching. The pulse width has a negligible effect on the magnetization for total fields below the switching field and on the peak in magnetization at the switching field.

Figures 4 and 5 show the change in magnetization resulting from the combination of the pulsed and bias fields. The bias field is responsible for a small reversible change in magnetization from negative saturation [Fig. 3(a)] which is constant with bias field. This is represented by the horizontal data at low fields in Figs. 4 and 5 for total fields below the switching field.

A simple model has been developed to aid interpretation of the magnetization switching behavior observed in the thin-film. The model considers a region within a magnetic thin-film with dimensions of the same order as the MOKE laser spot. The magnetization within the model is represented by the areas of two opposite magnetized domains separated by a single domain wall. In the model, switching takes place as this domain wall depins and propagates across the modeled region increasing the area of one domain with respect to the other. The reversible components of the magnetization observed in the experimental results are small and constant at each bias field and are, therefore, neglected in this model, although it is recognized that this is a simplification.

Figure 6(a) illustrates schematically the modeled region within a section of magnetic thin-film. Domain wall density in NiFe thin-films has been observed elsewhere to be dependent upon film thickness and have spacing of the order of a few micrometers, so modeling magnetization switching by the propagation of a single domain wall is a reasonable assumption for modeling on the 10 μm scale. Furthermore, the magnetization behavior of the macroscopic thin-film can be represented by the collective behavior of many such single domain walls across the thin-film. This single wall model is simplified, but based on reasonable assumptions and at most only a few domain walls are likely to contribute to magnetization switching in the area probed by the laser spot of the focused MOKE.

Magnetic field driven domain wall behavior has been modeled following Ferre et al. and Atkinson et al., who use a linear field dependent domain wall velocity:

\[ v = (\gamma \Delta/\alpha)H, \]  

dependent on the gyromagnetic ratio \( \gamma \), the domain wall width \( \Delta \), and damping coefficient \( \alpha \). Propagation at this velocity occurs for the remaining time of the field pulse following the wait time needed for the thermally activated depinning of the wall. This depinning time, \( \tau \), is obtained from a simple Arrhenius process:

\[ \tau = \tau_0 e^{\Delta E/k_B T}, \]  

where \( \tau_0 = 1 \times 10^{-9} \) s represents the inverse attempt frequency and \( k_B T \) the thermal energy at \( T=300 \) K. The energy barrier for the depinning processes is modeled as:

\[ \Delta E = E_0 (1 - H/H_0)^\beta, \]  

from the activation of a single process, using a zero temperature energy barrier, \( E_0 = 3 \times 10^{-20} \) J (comparable with experimental values obtained by Lendecke et al.), and zero temperature switching field \( H_0 = 30 \) Oe, which have been iterated so that the modeled behavior compares with experimental results obtained. The exponent \( \beta \) is set to a reasonable value of 1.5.

These energetic relationships are originally derived from switching in a single particle by coherent rotation. Modeling domain wall propagation as a single energy barrier process is a simplification, but this is reasonable because the details of the profile of the energy barrier are negligible in comparison to its height which is much greater than \( k_B T \).

At low fields, the energy barrier associated with the domain wall depinning for this reversal process is not overcome resulting in unsuccessful switching. When the total field is increased until it exceeds the switching field, the energy barrier can be overcome resulting in switching of the sample.

The model returns the normalized change in magnetization, \( M \), from negative saturation after the application of the pulsed and bias field for a propagation time followed by the bias field alone for a set measurement time;
spectrally. The pulse duration

time measured.

Here we note that the switching field increases with increasing bias field and measurement time. The complex peaked switching behavior arises from the inclusion of Walker breakdown in the field dependent velocity behavior.

Another feature in common between experimental and modeled results is the total field for switching. This field is independent of the relative contribution from pulsed and bias fields, in agreement with experimental results. In the model we ignore reversible magnetization rotation taking place within the samples. This accounts for the difference in the change in magnetization between experimental and modeled results for fields below the switching field. In the model, no change occurs to the magnetization as there is not enough energy to overcome the depinning energy and no reversible contributions are included in the model.

The effect of the width of the field pulse was also investigated using the model (see Fig. 9) for a constant bias field of $-0.1$ Oe. Modeled results show some features in common with the complex behavior found in experimental results. The final magnetization state for total fields below the switching field is independent of the pulse width and this switching field reduces with increasing pulse width. This is consistent with thermally activated switching processes.

**IV. CONCLUSIONS**

The magnetization behavior of a Permalloy thin-film has been investigated with a combination of quasistatic and pulsed magnetic fields. With a larger positive bias field, simple switching behavior is found where magnetization
switching takes place over a small field range and saturation is achieved with increasing of the field. In contrast, when the bias field is negative the magnetization behavior is more complex showing first a rapid rise in magnetization around the switching field. However, at higher fields switching measurements show reduced magnetization switching while for yet higher fields the level of magnetization switching increases.

This behavior has been modeled using a domain wall propagating in a region of magnetic thin-film on the 10 μm scale with a field dependent propagation that includes Walker breakdown. The model shows that for modest fields around the coercivity the magnetization switches fully as the domain walls can successfully propagate across the full width of the model in the duration of the pulse. For larger fields, Walker breakdown reduces the time averaged domain wall velocity so that the wall no longer reaches the far side of the model before the pulse is terminated. At this point the bias field then drives the domain wall motion. For larger positive bias fields the wall is driven to complete the magnetization switching while a negative bias field reverses the wall motion resulting in a less switched state. This simple model suggests a qualitative understanding of this complex behavior indicating that Walker breakdown of the domain wall propagation is limiting the magnetization switching behavior observed in Permalloy thin-film.